



# SIGC81T60SNC

#### IGBT Chip in NPT-technology

#### **FEATURES:**

- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient
- easy paralleling

#### This chip is used for:

## IGBT-Modules **Applications:** drives

Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code
SIGC81T60SNC	600V	100A	8.99 x 8.99 mm <sup>2</sup>	sawn on foil	Q67050-A4164- A003

#### **MECHANICAL PARAMETER:**

Raster size	8.99 x 8.99				
Area total / active	80.82 / 72.6				
Emitter pad size	8x( 1.77x2.82 )				
Gate pad size	0.78 x 1.51				
Thickness	100	μm			
Wafer size	150	mm			
Flat position	90	deg			
Max.possible chips per wafer	169				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	Al, ≤500μm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month				



## SIGC81T60SNC

#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V <sub>CE</sub>	600	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	100	А
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	200	А
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

#### **STATIC CHARACTERISTICS** (tested on chip), $T_j$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
i arameter			min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	V <sub>GE</sub> =0V, I <sub>C</sub> =4mA	600			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =100A	1.7	2.1	2.5	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I <sub>C</sub> =1.5mA, V <sub>GE</sub> =V <sub>CE</sub>	3	4	5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =600V, V <sub>GE</sub> =0V			300	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V, V <sub>GE</sub> =30V			300	nA

#### **DYNAMIC CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiametei	Symbol	Conditions	min.	typ.	max.	Oilit
Input capacitance	Ciss	V <sub>CE</sub> =25V	-	tbd	-	nF
Output capacitance	Coss	$V_{GE}=0V$	-	tbd	-	
Reverse transfer capacitance	Crss	f=1MHz	-	tbd	-	

#### **SWITCHING CHARACTERISTICS** (tested at component), Inductive Load:

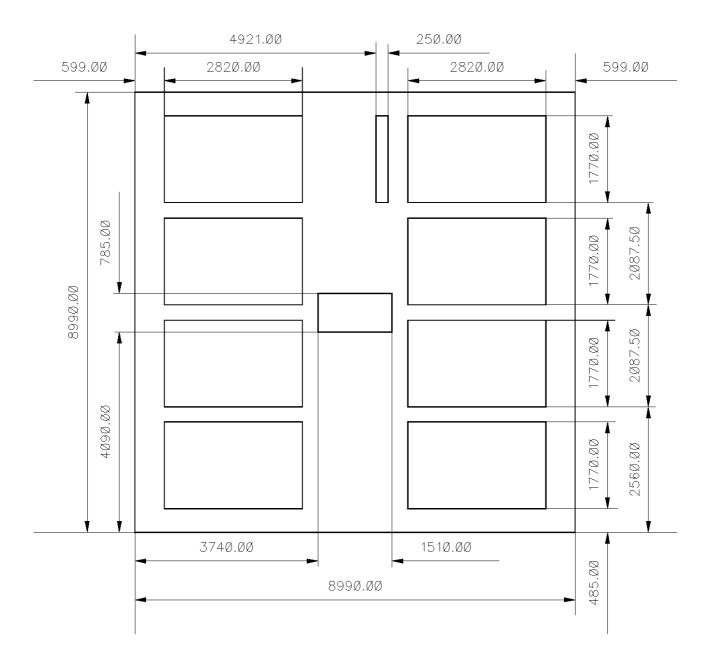
Parameter	Symbol	Conditions*	Value			Unit
rai ailletei			min.	typ.	max.	Uillt
Turn-on delay time	$t_{d(on)}$	$T_{\rm j}$ =150°C $V_{\rm CC}$ =400V	-	tbd	-	ns
Rise time	t <sub>r</sub>	I <sub>C</sub> =100A	-	tbd	-	
Turn-off delay time	$t_{d(off)}$	$V_{\text{GE}}$ =+15/0V $R_{\text{G}}$ = $\Omega$	-	tbd	-	
Fall time	t <sub>f</sub>	//G = 22	-	tbd	-	

<sup>\*</sup> switching conditions different to 600V LowLoss, under comparable switching conditions 40% faster turnoff than LowLoss



# SIGC81T60SNC

#### **CHIP DRAWING:**





#### **Preliminary**

### SIGC81T60SNC

#### **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet

BSM 100 GD 60 DLC

Econo Pack 3

#### **Description:**

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

Published by Infineon Technologies AG i Gr., Bereich Kommunikation St.-Martin-Strasse 53, D-81541 München © Infineon Technologies AG 1999 All Rights Reserved.

#### Attention please!

The information herein is given to describe certain components and shall not be considered as warranted characteristics.

Terms of delivery and rights to technical change reserved.

We hereby disclaim any and all warranties, including but not limited to warranties of non-infringement, regarding circuits, descriptions and charts stated herein.

Infineon Technologies is an approved CECC manufacturer.

#### Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office in Germany or our Infineon Technologies Representatives world-wide (see address list).

#### Warnings

Due to technical requirements components may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies components may only be used in life-support devices or systems with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and / or maintain and sustain and / or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.